

TRANSMITTAL OF INFORMATION DISCLOSURE STATEMENT
(Under 37 CFR 1.97(b) or 1.97(c))

Docket No.
1158.001CIP

In Re Application Of: **Schowalter et al**

Serial No.

Filing Date

Examiner

Group Art Unit

Title: **POWDER METALLURGY CRUCIBLE FOR ALUMINUM NITRIDE CRYSTAL GROWTH**

Address to:
Commissioner for Patents
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37 CFR 1.97(b)

1. ☒ The Information Disclosure Statement submitted herewith is being filed within three months of the filing of a national application other than a continued prosecution application under 37 CFR 1.53(d); within three months of the date of entry of the national stage as set forth in 37 CFR 1.491 in an international application; before the mailing of a first Office Action on the merits, or before the mailing of a first Office Action after the filing of a request for continued examination under 37 CFR 1.114.

37 CFR 1.97(c)

2. ☐ The Information Disclosure Statement submitted herewith is being filed after the period specified in 37 CFR 1.97(b), provided that the Information Disclosure Statement is filed before the mailing date of a Final Action under 37 CFR 1.113, a Notice of Allowance under 37 CFR 1.311, or an Action that otherwise closes prosecution in the application, and is accompanied by one of:

☐ the statement specified in 37 CFR 1.97(e);

OR

☐ the fee set forth in 37 CFR 1.17(p).

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Payment of Fee

(Only complete if Applicant elects to pay the fee set forth in 37 CFR 1.17(p))

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Dated: **4/12/04**

Richard L. Sampson, Reg. 37,231
Sampson & Associates, P.C.
50 Congress Street
Boston, MA 02109
US

CC:

INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>		Docket Number (Optional) 1158.001CIP	Application Number
		Applicant(s) Schowalter et al	
		Filing Date	Group Art Unit

*EXAMINER INITIAL	OTHER DOCUMENTS	<i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>
1.		G.A. Slack and T.F. McNelly, "Growth of High Purity AlN Crystals", J. Cryst. Growth 34, 263 (1976)
2.		G.A. Slack and T.F. McNelly, "AlN Single Crystals", J. Cryst. Growth 42, 560 (1977)
3.		B. Raghothamachar, M. Dudley, J.C. Rojo, K. Morgan, and L.J. Schowalter, "X-ray Characterization of Bulk AlN Single Crystals Grown by the Sublimation Technique", submitted to J. Crystal Growth (2002). Presented at Am. Assoc. Crystal Growth Conference. Seattle, WA, Aug. 2002.
4.		S.V. Nagender Naidu and P. Rama Rao, Editors, "Phase Diagrams of Binary Tungsten Alloys, Indian Institute of Metals", Calcutta, pp. 7-13, (1991).
5.		R. Dalmau, B. Raghothamachar, M. Dudley, R. Schlessner, and Z. Sitar, Materials Research Society Proc. Vol. 798, p. Y2.9.1 (2004).
6.		B.M. Epelbaum, D. Hofmann, M. Bickermann, A. Winnacker, Mater. Sci. Forum 389-393, 1445 (2002).
7.		G.A. Slack, J. Whitlock, K. Morgan, and L.J. Schowalter, Materials Research Society Proc. Vol. 798, p. Y10.74.1 (2004).
EXAMINER		DATE CONSIDERED

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.